

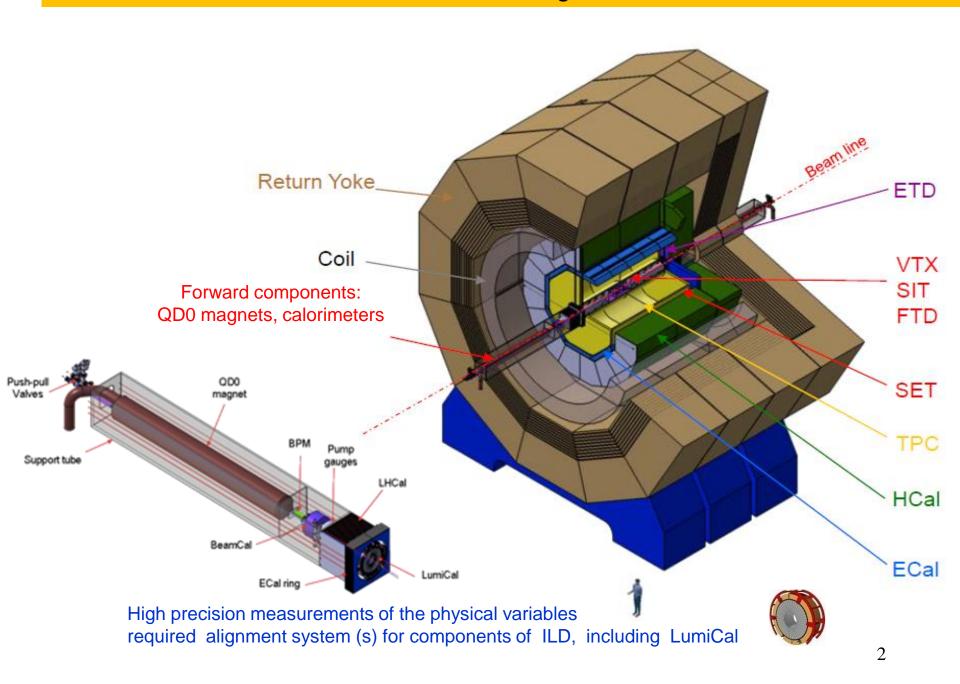


# **Laser Alignment System**

for LumiCal and BeamCal

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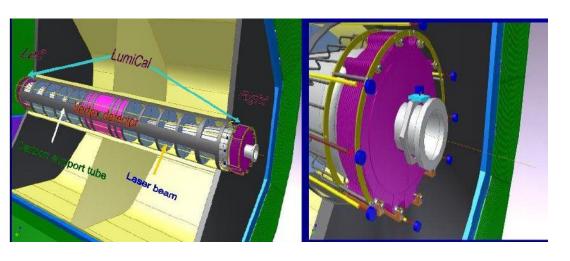
#### ILD: International Large Detector



## LumiCal alignment

High accuracy in luminosity measurements at ILC/CLIC ( $\Delta$ L/L ~ 10<sup>-3</sup> /10<sup>-2</sup>) require precisely measurement of the luminosity detector displacements: less than 500  $\mu$ m in X,Y directions , 100  $\mu$ m in Z direction and a few microns for internal silicon sensor layers

#### Mechanical aspect of LumiCal alignment

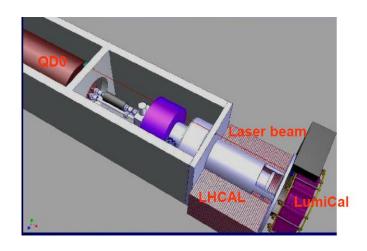


The measurements of absolute distance between Left and Right LumiCal calorimeters

The measurements of the relative distances to QD0 in X,Y and Z directions

Good reference points for position measurement of LumiCal can be:

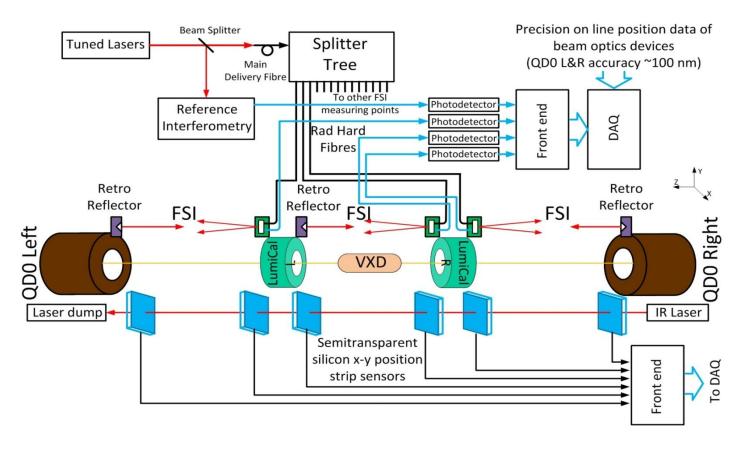
- QD0 magnet
- Beam Position Monitors
- also beam pipe



#### The design of the LAS system

The laser alignmet system will contain the main components:

- infra-red laser beam and semi-transparent position sensitive detectors (PSDs)
- tunable laser(s) working within Frequency Scanning Interferometry (FSI) system

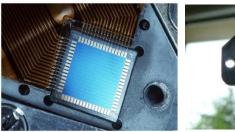


FSI – will be used for measurements of the absolute distance between LumiCal calorimeters by measurement of interferometer optical path differences using tunable lasers (by counting the frenges

Semi-transparent sensors: LumiCal displacements of the internal Si layers and detectors relative positions

A roughly estimation of the size of LAS output data is on the level of hundred kB/s and they will be included into LumiCal DAQ system

#### Semi-transparent sensors (PSD)





Anoce Strips

Active area 5 mm x 5 mm Strip pitch Strip gap as it hickness Indium Tilo Oxide Glass substrate

Active area 5 mm x 5 mm 10 um 100 um 10

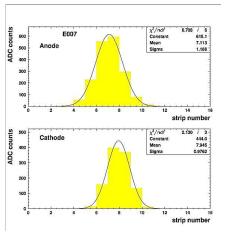
Quality testing of the sensors: microscope, probe station, and laser beam



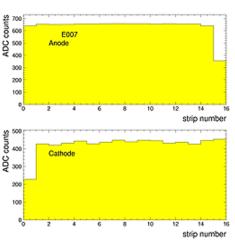
Semi - transparent amorphous silicon strip sensors, DPSD-516 - using laser with wavelength above ~ 780 nm, received from Oxford University,

High precision (ZEUS MVD)

position measurements in two coordinates X/Y: ~10  $\mu m$ 

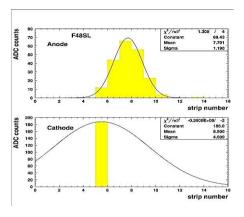


Proper shape of signals distributions from cathode and anode strips



Problem with some of the sensors: no signals from X or Y strips

9 high-quality sensors were selected and they will be used to construct a prototype of the positioning system in laboratory

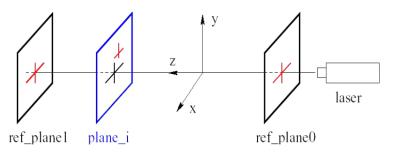


### Towards the laboratory prototype

VME: launch of the system LynxOS to read data from sensors



LAB - system prototype with optical movable table 2D Studies on the behaviour of the sensors, laser beam and calculation of the prototype displacements in ref. frame - actual accuracy.

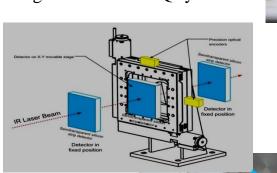


Roughly position calculations – mean values: mx, my

 $\begin{aligned} mx &= \Sigma_i \ x_i w_i \ my = \Sigma_i y_i w_i \\ with \ w_i &= I_i / \Sigma \ I_i \quad i = 1 \dots N \\ x_i, \ y_i \ - \ strip \ positions, \\ I_i \ - \ strip \ signals \end{aligned}$ 

#### or use a Wiener crate

VM-USB VME controller with USB2 interface: To read directly data from cards and for integration with DAQ system



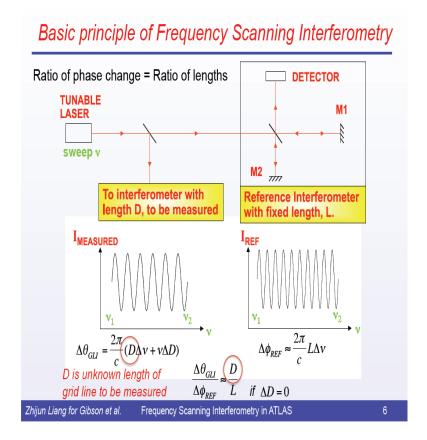




### Alignment system based on Frequency Scanning Interferometry

FSI technique enables remote, multiple, simultaneous and precide distance measurements.

It uses tunable lasers for measurement of interferometer optical path differences and provides an absolute distance measurements

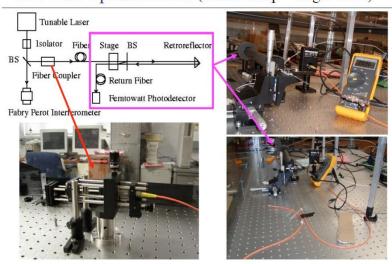




The first step: the tunable laser was purchased to laboratory power 10mW wavelength range: 663 – 678 nm

Next step: build in laboratory FSI system prototype (similar to that used for SiD (ATLAS concept)

FSI with Optical Fibers (initial setup - single laser)



Chen/Yang/Riles - Arlington LCWS - Oct 23, 2012

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# Summary

- Accuracy of X, Y position measurement using semi-transparent strip sensors can reach ~10 μm
- The readout electronics can be placed outside ILD, but log cables decreases accuracy and consume space
- FSI looks very promising used in many HEP experiments
- Accuracy of very simple FSI absolute distance measurement in air can reach ~10-20 μm in X, Y and ~30 μm for Z
- More sophisticated FSI methods can give ~100 nm (or better) accuracy
- FSI equipment (Tunable Laser ~10k€, Controller ~5k€,
   Optics/FO etc. ~100€/measuring point) is expensive for low amount of measuring points.
- The FSI laser beam can be splitted up to ~1000 measuring points.